# THIS PAGE IS INSERTED BY OIPE SCANNING AND IS NOT PART OF THE OFFICIAL RECORD

#### **Best Available Images**

Defective images within this document are accurate representations of the original documents submitted by the applicant.

Defects in the images may include (but are not limited to):

**BLACK BORDERS** 

TEXT CUT OFF AT TOP, BOTTOM OR SIDES

**FADED TEXT** 

**BLURRY OR ILLEGIBLE TEXT** 

SKEWED/SLANTED IMAGES

COLORED PHOTOS HAVE BEEN RENDERED INTO BLACK AND WHITE

VERY DARK BLACK AND WHITE PHOTOS

UNDECIPHERABLE GRAY SCALE DOCUMENTS

IMAGES ARE THE BEST AVAILABLE COPY. AS RESCANNING WILL NOT CORRECT IMAGES, PLEASE DO NOT REPORT THE IMAGES TO THE PROBLEM IMAGE BOX.

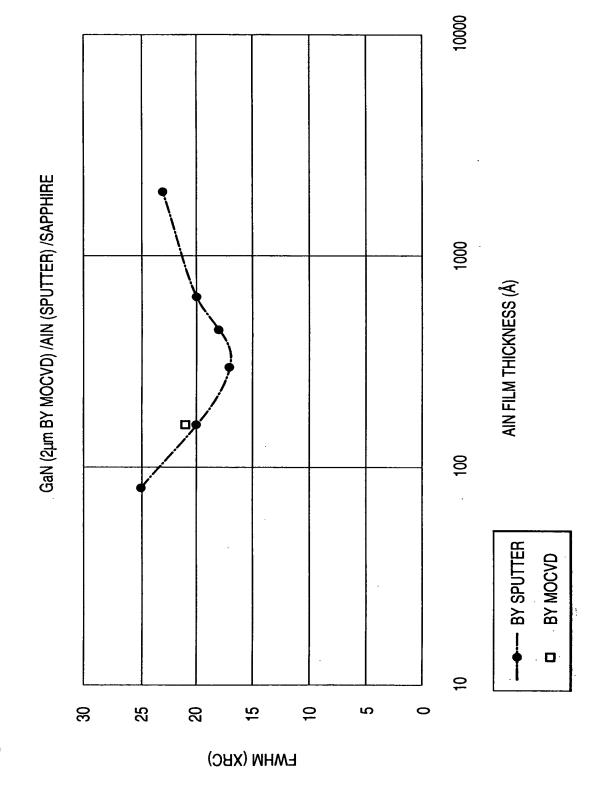


FIG. 1

100 001

8 GaN (2µm BY MOCVD) /AIN (SPUTTER) / SAPPHIRE TEMPERETURE OR SUBSTRATE FOR FILM GROWTH (SURFACE) (°C) FIG. 2 BY MOCVD (REFERENCE) **5**00 - BY SPUTTER 8 22 **\$** ജ റ്റ **9** 0 емни (хвс)

FIG. 3

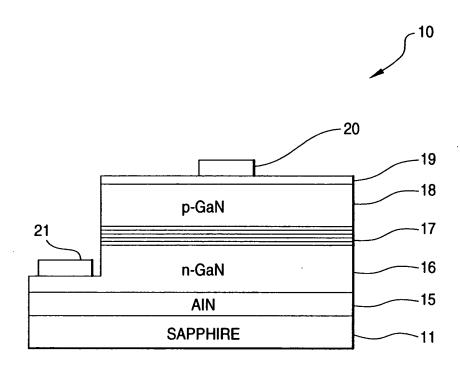


FIG. 4

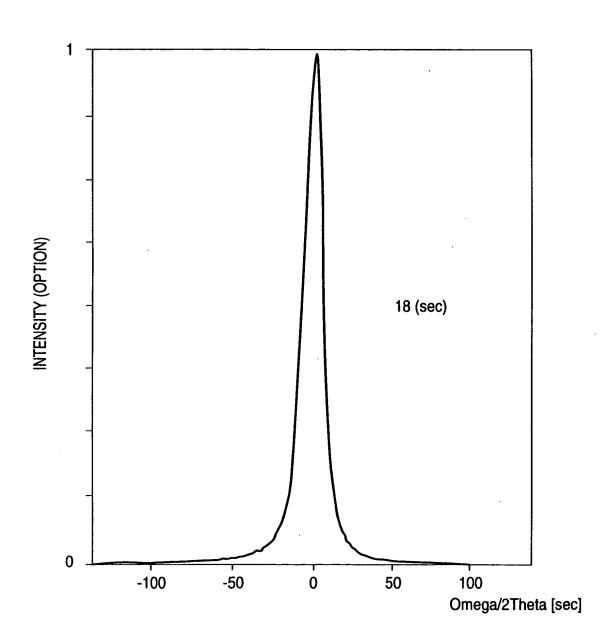


FIG. 5

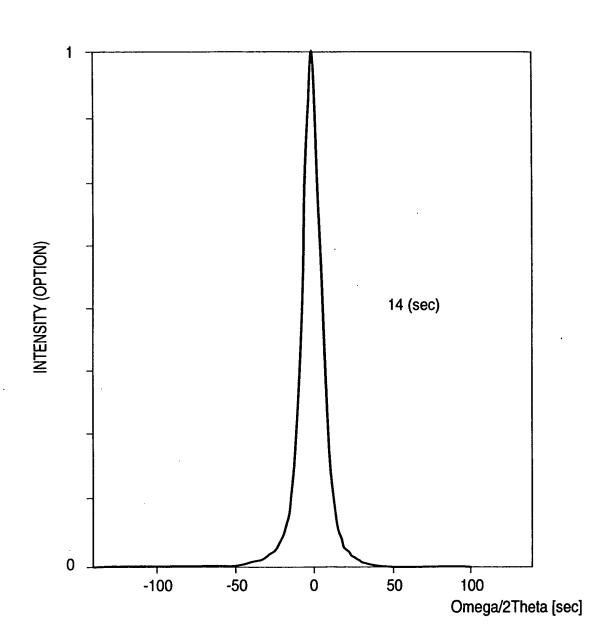


FIG. 6

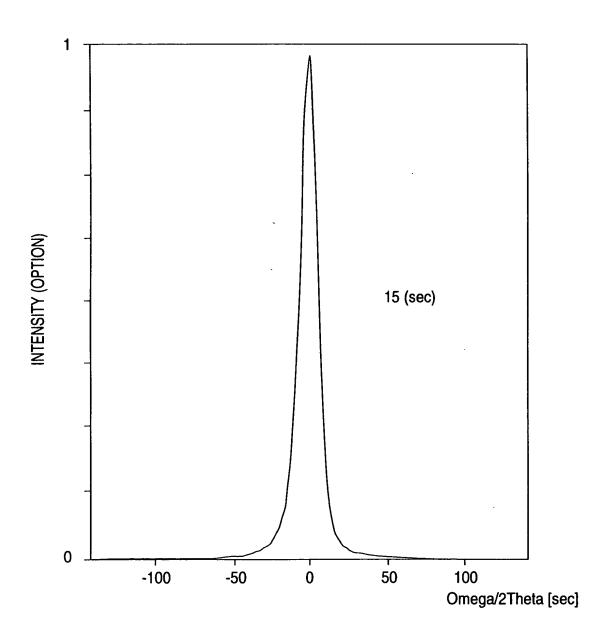


FIG. 10



FIG. 9



### BEST AVAILABLE COPY

# FIG. 8

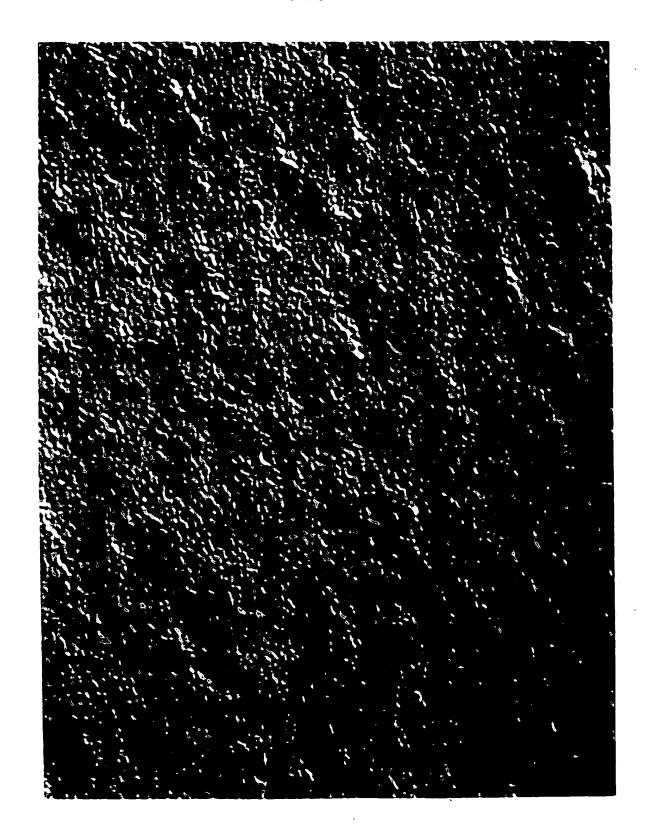


FIG. 7D

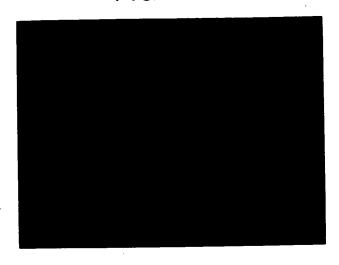


FIG. 7E

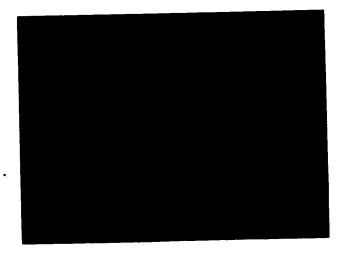


FIG. 7A

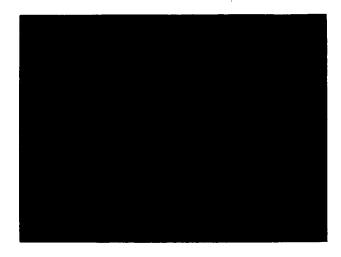


FIG. 7B

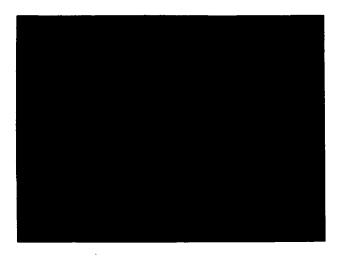
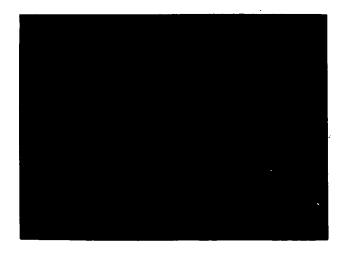


FIG. 7C



## FIG. 11

